## Notice of References Cited Application/Control No. 09/894,862 Examiner Thai Q. Phan Applicant(s)/Patent Under Reexamination LEE ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,500,323 B1	12-2002	Chow et al.	204/450
	В	US-6,569,382 B1	05-2003	Edman et al.	422/68.1
	С	US-6,637,463 B1	10-2003	Lei et al.	137/803
	D	US-6,829,753 B2	12-2004	Lee et al.	716/5
	E	US-2002/0108097 A1	08-2002	Harris et al.	716/11
	F	US-2002/0197603 A1	12-2002	CHOW et al.	435/6
	G	US-2004/0096960 A1	05-2004	Burd Mehta et al.	435/287.2
	н	US-2002/0037499 A1	03-2002	Quake et al.	435/5
	ı	US-			
	J	US-			
1	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	Р					
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	S					
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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